

<b>Notice of References Cited</b>	Application/Control No. 10/535,318		Applicant(s)/Patent Under Reexamination DENG ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0077094	06-2002	LEPPANEN, REIJO	455/420
	B	US-			
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